


<b>Search Notes</b>  	<b>Application/Control No.</b>  10533456	<b>Applicant(s)/Patent Under Reexamination</b>  MASHITANI ET AL.
	<b>Examiner</b>  HEE-YONG KIM	<b>Art Unit</b>  4192

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
stereoscopic and (pixel group)	7/02	H.K
(repeat near pixel)and interpolation	7/06	H.K
square pixel	7/01	H.K
1997JP-038896.ap.	6/26	H.K

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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